

<b>Notice of References Cited</b>	Application/Control No. 09/828,149	Applicant(s)/Patent Under Reexamination WASENIUS, REIDAR	
	Examiner Raymond S. Dean	Art Unit 2684	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,901,434	05-2005	Lunsford et al.	709/216
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Haartsen, J.C.; Mattisson, S.; Proceedings of the IEEE, Volume: 88, Issue: 10, Oct. 200 Pages 1651 - 1661
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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